Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
08/964,257	TERASHIMA ET AL.	
Examiner	Art Unit	
Madeleine AV Nauven	2626	

SEARCHED					
Class	Subclass	Date	Examiner		
update		10/15/2005	AV		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

(INCLUDING SEAR	CH STRATEGY	)
	DATE	EXMR
East	10/15/2005	AV